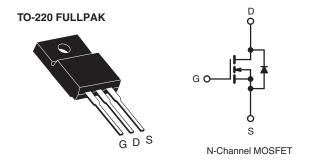


Vishay Siliconix

Power MOSFET

PRODUCT SUMMARY				
V _{DS} (V)	60			
$R_{DS(on)}\left(\Omega\right)$	V _{GS} = 5.0 V	0.050		
Q _g (Max.) (nC)	35			
Q _{gs} (nC)	7.1			
Q _{gd} (nC)	25			
Configuration	Single			



FEATURES

- · Isolated Package
- High Voltage Isolation = 2.5 kV_{RMS} (t = 60 s; f = 60 Hz



- Sink to Lead Creepage Distance 4.8 mm
- · Logic-Level Gate Drive
- R_{DS(on)} Specified at V_{GS} = 4 V and 5 V
- · Fast Switching
- · Ease of paralleling
- · Lead (Pb)-free

DESCRIPTION

Third generation Power MOSFETs from Vishay provide the designer with the best combination of fast switching, ruggedized device design, low on-resistance and cost-effectiveness.

The TO-220 FULLPAK eliminates the need for additional insulating hardware in commercial-industrial applications. The molding compound used provides a high isolation capability and a low thermal resistance between the tab and external heatsink. This isolation is equivalent to using a 100 micron mica barrier with standard TO-220 product. The FULLPAK is mounted to a heatsink using a single clip or by a single screw fixing.

ORDERING INFORMATION	
Package	TO-220 FULLPAK
Lead (Pb)-free	IRLIZ34GPbF
Lead (PD)-liee	SiHLIZ34G-E3
SnPb	IRLIZ34G
SIIFU	SiHLIZ34G

PARAMETER			SYMBOL	LIMIT	UNIT	
Drain-Source Voltage			V _{DS}	60	V	
Gate-Source Voltage			V _{GS}	± 10	1 v	
Continuous Drain Current	V _{GS} at 5.0 V	T _C = 25 °C	I _D	20	А	
		T _C = 100 °C		14		
Pulsed Drain Current ^a			I _{DM}	80		
Linear Derating Factor				0.28	W/°C	
Single Pulse Avalanche Energy ^b			E _{AS}	200	mJ	
Maximum Power Dissipation	T _C = 25 °C		P _D	42	W	
Peak Diode Recovery dV/dt ^c			dV/dt	4.5	V/ns	
Operating Junction and Storage Temperature Range		T _J , T _{stg}	- 55 to + 175	°C		
Soldering Recommendations (Peak Temperature)	for 10 s			300 ^d	7	
Mounting Torque	6 22 or l	6-32 or M3 screw		10	lbf ⋅ in	
	0-02 of M3 sciew			1.1	N · m	

Notes

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
- b. $V_{DD} = 25 \text{ V}$, starting $T_J = 25 \,^{\circ}\text{C}$, $L = 583 \, \mu\text{H}$, $R_G = 25 \, \Omega$, $I_{AS} = 20 \, \text{A}$ (see fig. 12c). c. $I_{SD} \le 30 \, \text{A}$, $dI/dt \le 200 \, \text{A}/\mu\text{s}$, $V_{DD} \le V_{DS}$, $T_J \le 175 \,^{\circ}\text{C}$.
- d. 1.6 mm from case.

^{*} Pb containing terminations are not RoHS compliant, exemptions may apply

IRLIZ34G, SiHLIZ34G

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THERMAL RESISTANCE RATINGS					
PARAMETER	SYMBOL	TYP.	MAX.	UNIT	
Maximum Junction-to-Ambient	R _{thJA}	-	65	°C/W	
Maximum Junction-to-Case (Drain)	R _{thJC}	-	3.6	C/VV	

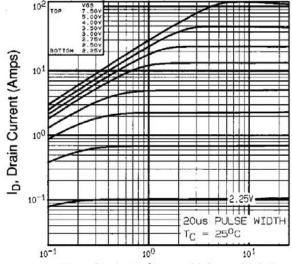
PARAMETER	SYMBOL	TEST CONDITIONS		MIN.	TYP.	MAX.	UNIT
Static							
Drain-Source Breakdown Voltage	V _{DS}	V _{GS} =	60	-	-	٧	
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	Reference to 25 °C, I _D = 1 mA		-	0.070	-	V/°C
Gate-Source Threshold Voltage	V _{GS(th)}	V _{DS} = V _{GS} , I _D = 250 μA		1.0	-	2.0	V
Gate-Source Leakage	I _{GSS}	V _{GS} = ± 10 V		-	-	± 100	nA
Zava Cata Valtaga Dvain Cuvvant	1	V _{DS} = 60 V, V _{GS} = 0 V		-	-	25	
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} = 48 V,	V _{GS} = 0 V, T _J = 150 °C	-	-	250	μΑ
Dunin Course On Otata Basistana	Ь	V _{GS} = 5.0 V	I _D = 12 A ^b	-	-	0.050	
Drain-Source On-State Resistance	$R_{DS(on)}$	V _{GS} = 4.0 V	I _D = 10 A ^b	-	-	0.070	Ω
Forward Transconductance	9 _{fs}	V _{DS} = 25 V, I _D = 12 A ^b		12	-	-	S
Dynamic							
Input Capacitance	C _{iss}	$V_{GS} = 0 \text{ V},$ $V_{DS} = 25 \text{ V},$ $f = 1.0 \text{ MHz, see fig. 5}$ $f = 1 \text{ MHz}$		-	1600	-	- - pF
Output Capacitance	C _{oss}			-	660	-	
Reverse Transfer Capacitance	C _{rss}			-	170	-	
Drain to Sink Capacitance	С			-	12	-	
Total Gate Charge	Qg			-	-	35	nC
Gate-Source Charge	Q _{gs}	V _{GS} = 5.0 V	$V_{GS} = 5.0 \text{ V}$ $I_D = 30 \text{ A}, V_{DS} = 48 \text{ V},$ see fig. 6 and 13 ^b	-	-	7.1	
Gate-Drain Charge	Q_{gd}]		-	-	25	
Turn-On Delay Time	t _{d(on)}	V_{DD} = 30 V, I_{D} = 30 A, R_{G} = 6.0 Ω, R_{D} = 1.0 Ω, see fig. 10 ^b		-	14	-	- ns
Rise Time	t _r			-	170	-	
Turn-Off Delay Time	t _{d(off)}			-	30	-	
Fall Time	t _f			-	56	-	
Internal Drain Inductance	L _D	Between lead, 6 mm (0.25") from package and center of die contact		-	4.5	-	
Internal Source Inductance	L _S			-	7.5	-	- nH
Drain-Source Body Diode Characteristic	s	•		1	Į	<u>. </u>	
Continuous Source-Drain Diode Current	I _S	MOSFET symbol showing the integral reverse p - n junction diode		-	-	20	- A
Pulsed Diode Forward Current ^a	I _{SM}			-	-	80	
Body Diode Voltage	V_{SD}	$T_J = 25$ °C, $I_S = 20$ A, $V_{GS} = 0$ V ^b		-	-	1.6	V
Body Diode Reverse Recovery Time	t _{rr}	T 05 °C 1	20 A dl/dt 100 A/:h	-	90	180	ns
Body Diode Reverse Recovery Charge	Q _{rr}	$T_J = 25 ^{\circ}\text{C}, I_F = 30 \text{A}, dI/dt = 100 \text{A/} \mu \text{s}^{\text{b}}$		-	0.65	1.3	μC
Forward Turn-On Time	t _{on}	Intrinsic tu	-on is don	ninated by	L _S and I	_D)	

Notes

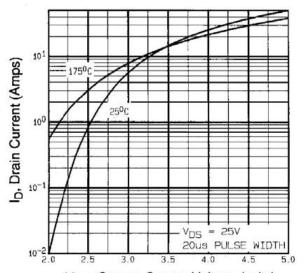
- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
- b. Pulse width $\leq 300~\mu s;$ duty cycle $\leq 2~\%.$



TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted



 V_{DS} , Drain-to-Source Voltage (volts) Fig. 1 - Typical Output Characteristics, $T_C = 25$ °C



V_{GS}, Gate-to-Source Voltage (volts) Fig. 3 - Typical Transfer Characteristics

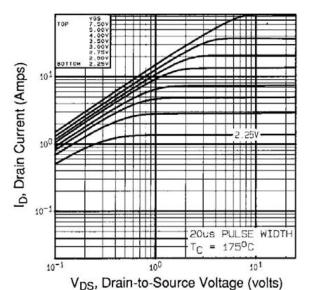


Fig. 2 - Typical Output Characteristics, T_C = 175 °C

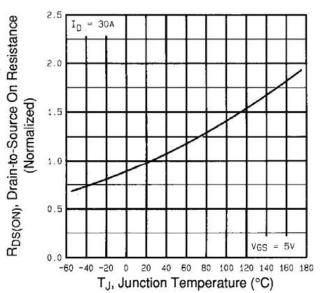


Fig. 4 - Normalized On-Resistance vs. Temperature

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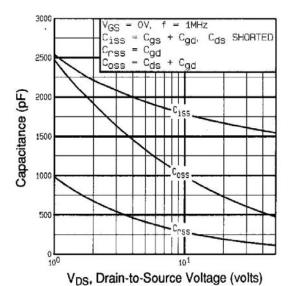


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

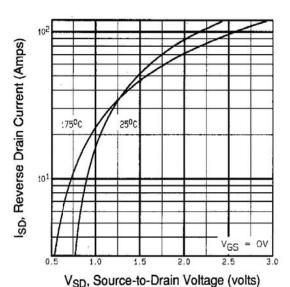


Fig. 7 - Typical Source-Drain Diode Forward Voltage

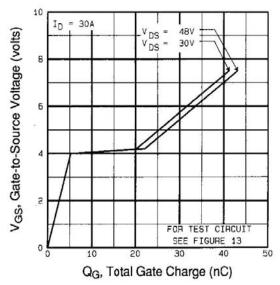


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage

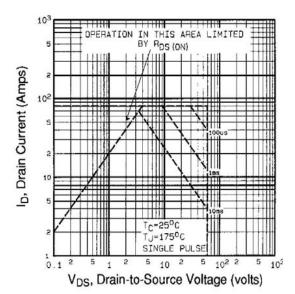


Fig. 8 - Maximum Safe Operating Area



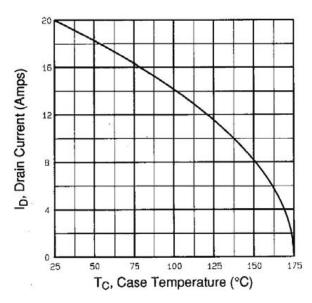


Fig. 9 - Maximum Drain Current vs. Case Temperature

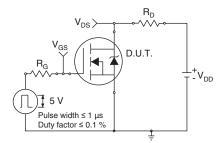


Fig. 10a - Switching Time Test Circuit

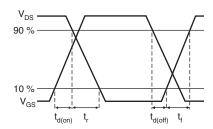


Fig. 10b - Switching Time Waveforms

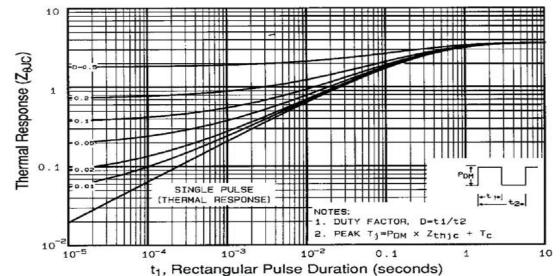


Fig. 11 - Maximum Effective Transient Thermal Impedance, Junction-to-Case

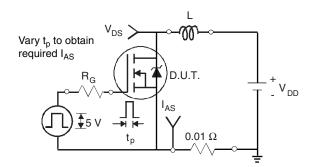


Fig. 12a - Unclamped Inductive Test Circuit

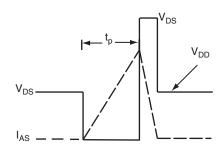
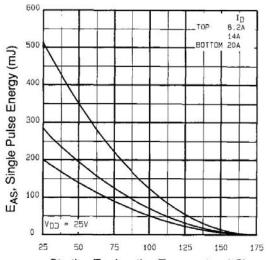


Fig. 12b - Unclamped Inductive Waveforms

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Starting T_J, Junction Temperature(°C)
Fig. 12c - Maximum Avalanche Energy vs. Drain Current

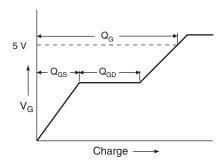


Fig. 13a - Basic Gate Charge Waveform

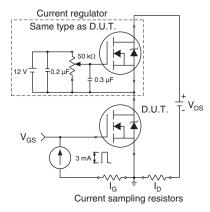
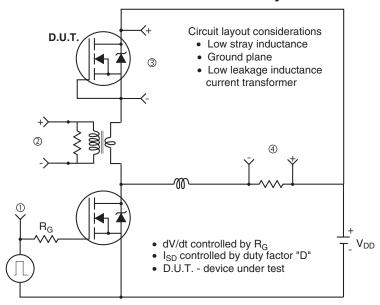
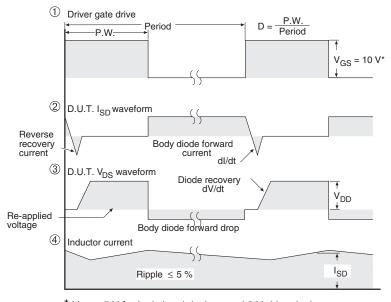


Fig. 13b - Gate Charge Test Circuit



Peak Diode Recovery dV/dt Test Circuit





 * V_{GS} = 5 V for logic level devices and 3 V drive devices

Fig. 14 - For N-Channel

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